

N-Channel 500-V (D-S) Super Junction MOSFET

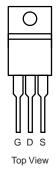
PRODUCT SUMMARY					
V _{DS} (V) at T _J max.	500				
R _{DS(on)} at 25 °C (Ω)	V _{GS} = 10 V	0.115			
Q _g (Max.) (nC)	86				
Q _{gs} (nC)	14				
Q _{gd} (nC)	25				
Configuration	Single				

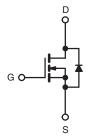
FEATURES

- Low figure-of-merit (FOM): Ron x Qa
- Low input capacitance (Ciss)
- Reduced switching and conduction losses
- Low gate charge (Qa)
- Avalanche energy rated (UIS)



TO-220AB





N-Channel MOSFET

APPLICATONS

- · Hard switched topologies
- Power factor correction power supplies (PFC)
- Switch mode power supplies (SMPS)
- Computing
 - PC silver box / ATX power supplies
- Lighting
 - Two stage LED lighting

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	500	V	
Gate-Source Voltage			V_{GS}	± 30	v	
Continuous Drain Comment /T 150 °C\	V _{GS} at 10 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$	- I _D	30		
Continuous Drain Current (T _J = 150 °C)	V _{GS} at 10 V	T _C = 100 °C		18	А	
Pulsed Drain Current ^a			I _{DM}	105		
Linear Derating Factor				0.2	W/°C	
Single Pulse Avalanche Energy b			E _{AS}	273	mJ	
Maximum Power Dissipation			P_{D}	280	W	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +150	°C	
Drain-Source Voltage Slope	$V_{DS} = 0 \text{ V to } 80 \text{ % } V_{DS}$		d\//d+	65		
Reverse Diode dV/dt d			dV/dt	25	- V/ns	
Soldering Recommendations (Peak Temperature) c	c for 10 s			300	°C	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature.
- b. V_{DD} = 50 V, starting T_J = 25 °C, L = 28.2 mH, R_g = 25 Ω , I_{AS} = 4.4 A.
- c. 1.6 mm from case.
- d. $I_{SD} \le I_D$, $dI/dt = 100 \text{ A/}\mu\text{s}$, starting $T_J = 25 \,^{\circ}\text{C}$.

THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	40	°C/W	
Maximum Junction-to-Case (Drain)	R_{thJC}	-	0.5	C/VV	

服务热线:400-655-8788

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PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static					•		
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		500	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	Reference to 25 °C, I _D = 1 mA		0.59	-	V/°C
Gate-Source Threshold Voltage (N)	V _{GS(th)}	V _{DS} =	$V_{DS} = V_{GS}, I_D = 250 \mu A$		-	4.0	V
0.1.0		$V_{GS} = \pm 20 \text{ V}$		-	-	± 100	nA
Gate-Source Leakage	I _{GSS}		V _{GS} = ± 30 V	-	-	± 1	μΑ
Zero Gate Voltage Drain Current		V _{DS} =	= 500 V, V _{GS} = 0 V	-	-	1	,^
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 400 \	V _{DS} = 400 V, V _{GS} = 0 V, T _J = 125 °C		-	25	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 12 A	-	0.115	-	Ω
Forward Transconductance	9 _{fs}	V _{DS}	= 30 V, I _D = 12 A	-	6.6	-	S
Dynamic							
Input Capacitance	C _{iss}		$V_{GS} = 0 V$,	-	1980	-	
Output Capacitance	C _{oss}		$V_{DS} = 100 V,$	-	105	-	
Reverse Transfer Capacitance	C_{rss}		f = 1 MHz	-	8	-	
Effective Output Capacitance, Energy Related ^a	C _{o(er)}	V 0V 400 V V 0V		-	105	-	pF -
Effective Output Capacitance, Time Related ^b	C _{o(tr)}	V _{DS} = 0 \	$V_{DS} = 0 \text{ V to } 400 \text{ V}, V_{GS} = 0 \text{ V}$		285	-	
Total Gate Charge	Qg			-	57	86	
Gate-Source Charge	Q _{gs}	$V_{GS} = 10 \text{ V}$ $I_D = 12 \text{ A}, V_{DS} = 400 \text{ V}$		-	14	-	nC
Gate-Drain Charge	Q _{gd}			-	25	-	
Turn-On Delay Time	t _{d(on)}			-	19	38	
Rise Time	t _r	$V_{DD} = 400 \text{ V}, I_D = 12 \text{ A}$ $R_g = 9.1 \Omega, V_{GS} = 10 \text{ V}$		-	36	72	ns
Turn-Off Delay Time	t _{d(off)}			-	57	86	
Fall Time	t _f			-	29	58	1
Gate Input Resistance	R _g	f = 1	f = 1 MHz, open drain		0.56	-	Ω
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	Is	MOSFET symbol showing the integral reverse p - n junction diode		-	-	12	
Pulsed Diode Forward Current	I _{SM}			-	-	50	- A
Diode Forward Voltage	V _{SD}	T _J = 25 °C	s, I _S = 16.5 A, V _{GS} = 0 V	-	-	1.2	V
Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = I _S , dI/dt = 100 A/ μ s, V _R = 25 V		-	338	-	ns
Reverse Recovery Charge	Q _{rr}			-	5.3	-	μC
Reverse Recovery Current	I _{RRM}			-	29	-	A

a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

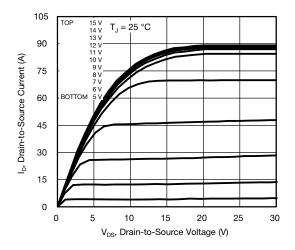


Fig. 1 - Typical Output Characteristics

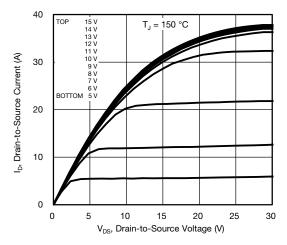


Fig. 2 - Typical Output Characteristics

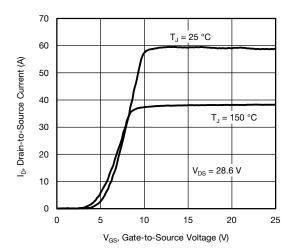


Fig. 3 - Typical Transfer Characteristics

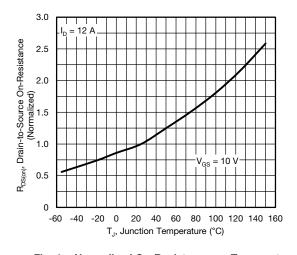


Fig. 4 - Normalized On-Resistance vs. Temperature

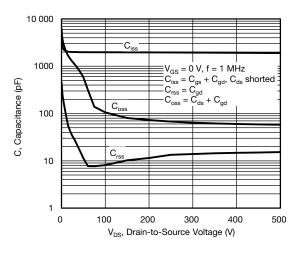


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

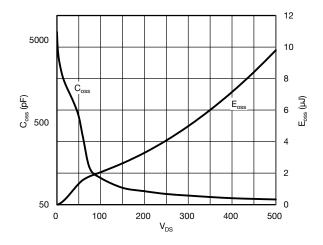


Fig. 6 - $C_{\mbox{\scriptsize OSS}}$ and $E_{\mbox{\scriptsize OSS}}$ vs. $V_{\mbox{\scriptsize DS}}$



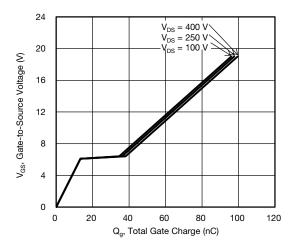


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

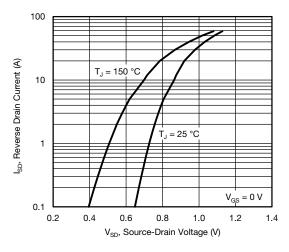


Fig. 8 - Typical Source-Drain Diode Forward Voltage

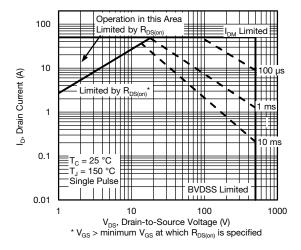


Fig. 9 - Maximum Safe Operating Area

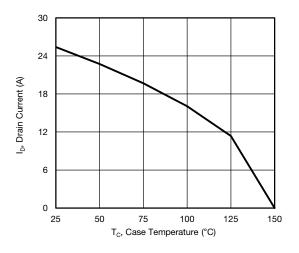


Fig. 10 - Maximum Drain Current vs. Case Temperature

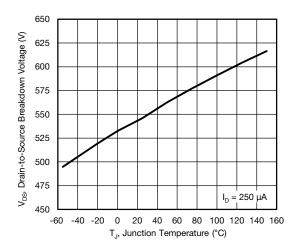


Fig. 11 - Typical Drain-to-Source Voltage vs. Temperature



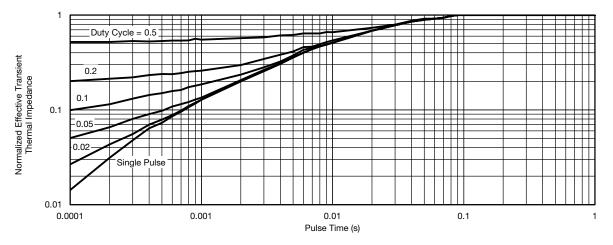


Fig. 12 - Normalized Thermal Transient Impedance, Junction-to-Case

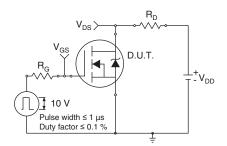


Fig. 13 - Switching Time Test Circuit

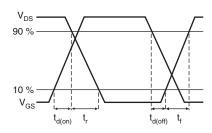


Fig. 14 - Switching Time Waveforms

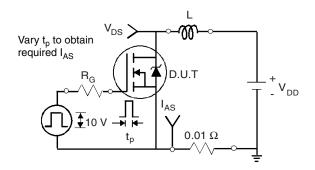


Fig. 15 - Unclamped Inductive Test Circuit

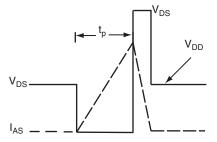


Fig. 16 - Unclamped Inductive Waveforms

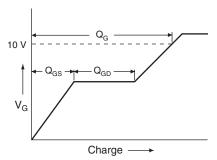


Fig. 17 - Basic Gate Charge Waveform

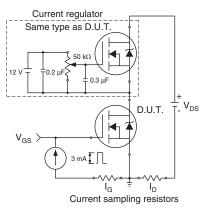
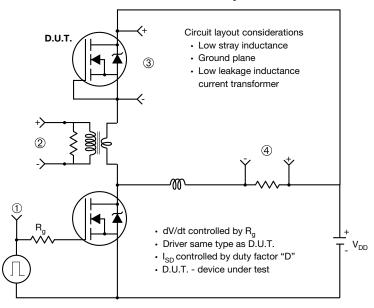


Fig. 18 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



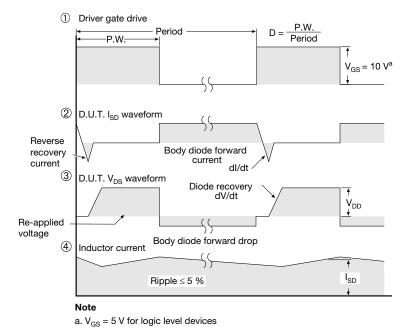
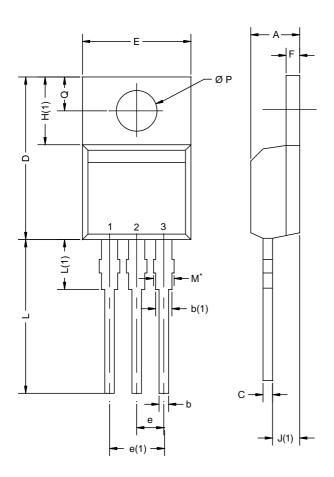


Fig. 19 - For N-Channel



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	MILLIN	IETERS	INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
Α	4.25	4.65	0.167	0.183	
b	0.69	1.01	0.027	0.040	
b(1)	1.20	1.73	0.047	0.068	
С	0.36	0.61	0.014	0.024	
D	14.85	15.49	0.585	0.610	
Е	10.04	10.51	0.395	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.09	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.35	14.02	0.526	0.552	
L(1)	3.32	3.82	0.131	0.150	
ØΡ	3.54	3.94	0.139	0.155	
Q	2.60	3.00	0.102	0.118	
ECN: X12-0208-Rev. N, 08-Oct-12 DWG: 5471					

Notes

 $^{^{\}star}$ M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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